Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/729,902	LEE, WOO-CHANG		
Examiner	Art Unit		
Stephen J. Castellano	3727		

SEARCHED					
Class	Subclass	Date	Examiner		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
114/256, 257, 74T - US PAT + US PG Pub only 114/74A (first 243), 74R (first 132) - US Pat + US PG Pub only	7/6/2006	SJC	